



SEMI E1.9-0299

PROVISIONAL MECHANICAL SPECIFICATION FOR CASSETTES USED TO TRANSPORT AND STORE 300-mm WAFERS

1. Purpose

1.1 This standard specifies the cassettes used to transport and store 300-mm wafers in an IC manufacturing facility. This includes both manual and auto-transport use as well as high-speed extraction of the wafers in processing equipment.

2. Scope

2.1 This standard is intended to set an appropriate level of specification that places minimal limits on innovation while ensuring modularity and interchangeability at all mechanical interfaces. Most of the requirements given in this specification are in the form of maximum or minimum dimensions with very few required surfaces. Only the mechanical interfaces for cassettes are specified; no materials requirements or micro-contamination limits are given. However, this standard has been written so that both metal and injection-molded plastic cassettes can be manufactured in conformance with it.

2.2 The cassette has the following components and sub-components, and other features. A "†" symbol indicates components or features that include dimensions required for boxes with non-removable cassettes.

- 1 top domain
- 2 optical wafer sensing paths
 - 4 robotic handling flanges (optional)
 - 1 top cassette identification tag area (optional)
- 2 or 4 side domains (2 in front and 2 in rear, if needed)
- supports (for 13 or 25 wafers) with correct wafer pitch (10 mm) †
- 1 optical cassette sensing hole on each front side domain
- 1 side cassette identification tag area on front right side domain only
 - features that prevent wafer creep-out (optional)
 - 2 pentagonal side grip pits on each front side domain (optional)

- 1 bottom domain
- 2 optical wafer sensing paths
- 5 carrier sensing pads †
- 4 info pads †
- 1 pod latch-pin hole
- 2 conveyor rails
- 2 fork-lift pick-up areas
- 2 fork-lift pin holes
- 3 features that mate with kinematic coupling pins and provide a 10-mm lead in †
 - 3 features that mate with kinematic coupling pins and provide a 15-mm lead in (optional)
 - 1 bottom cassette identification tag area (optional)
- Other features
 - multiple horizontal wafer sensing paths
 - 2 end-effector exclusion zones †

2.3 This standard is provisional because of concerns about the kinematic coupling pins causing excessive wear on carriers, the pitch being too small, and the usefulness of the robotic handling flanges, side grip pits, fork-lift slots, and conveyor rails. Also, additional features may need to be added to allow the wafers to be more easily accessed in a vertical orientation. Once cassette testing is done, this standard should be modified and upgraded from provisional status.

3. Referenced Documents

3.1 SEMI Standards

SEMI E15 — Specification for Tool Load Port

SEMI E19 — Standard Mechanical Interface (SMIF)

SEMI E44 — Guide for Procurement and Acceptance of Minienvironments

SEMI E57 — Provisional Mechanical Specification for Kinematic Couplings Used to Align and Support 300 mm Wafer Carriers



4. Terminology

- 4.1 *bilateral datum plane* — A vertical plane that bisects the wafers and that is perpendicular to both the horizontal and facial datum planes (as defined in SEMI E57).
- 4.2 *box* — A protective portable container for a cassette and/or substrate(s) (as defined in SEMI E44).
- 4.3 *carrier capacity* — The number of substrates that a carrier holds.
- 4.4 *cassette* — An open structure that holds one or more substrates (as defined in SEMI E44).
- 4.5 *cassette bottom domain* — Volume (below z6 above the horizontal datum plane) that contains the bottom of the cassette.
- 4.6 *cassette sensing pads* — Surfaces on the bottom of the cassette for triggering optical or mechanical sensors.
- 4.7 *cassette side domains* — Volumes (from z6 above the horizontal datum plane to z15 above the top nominal wafer seating plane) that contain the mizo teeth or slots that support the wafer and the supporting columns on the sides and rear of the cassette.
- 4.8 *cassette top domain* — Volume (higher than z15 above the top wafer) that contains the top of the cassette.
- 4.9 *conveyor rails* — Parallel edges on the bottom of the cassette for supporting the cassette on roller conveyors.
- 4.10 *facial datum plane* — A vertical plane that bisects the wafers and that is parallel to the front side of the carrier (where wafers are removed or inserted). On tool load ports, it is also parallel to the load face plane specified in SEMI E15 on the side of the tool where the carrier is loaded and unloaded (as defined in SEMI E57).
- 4.11 *fork-lift slots* — Rectangular holes (open to the front and rear) in the bottom of the cassette for picking up the cassette with a fork.
- 4.12 *front-opening unified pod (FOUP)* — A box (that complies with SEMI E47.1) with a non-removable cassette (so that its interior complies with SEMI E1.9) and with a front-opening interface (that mates with a FIMS port that complies with SEMI E62) (as defined in SEMI E47.1).
- 4.13 *horizontal datum plane* — A horizontal plane from which projects the kinematic-coupling pins on which the carrier sits. On tool load ports, it is at the load height specified in SEMI E15 and might not be

physically realized as a surface (as defined in SEMI E57).

- 4.14 *nominal wafer center line* — The line that is defined by the intersection of the two vertical datum planes (facial and bilateral) and that passes through the nominal centers of the seated wafers (which must be horizontal when the carrier is placed on the coupling) (as defined in SEMI E57).
- 4.15 *nominal wafer seating plane* — Horizontal plane that bisects the wafer pick-up volume.
- 4.16 *optical wafer sensing paths* — Lines of sight for optically sensing the positions of the wafers. Several horizontal optical wafer sensing paths are present in between the cassette side domains. In addition, two vertical optical wafer sensing paths are created by rectangular exclusion zones in the front of the cassette top and bottom.
- 4.17 *pod* — A box having a Standard Mechanical Interface (SMIF) per SEMI E19 (as defined in SEMI E44).
- 4.18 *process batch* — A set of substrates that are processed simultaneously in a process chamber.
- 4.19 *robotic handling flanges* — Four horizontal projections on top of the cassette for lifting and rotating the cassette.
- 4.20 *sensor hole* — An indentation on the bottom of the cassette for inserting optical sensors.
- 4.21 *side grip pits* — Two rectangular indentations on each side of the cassette for lifting and rotating the cassette.
- 4.22 *transport group* — A set of substrates that are transported together between tools.
- 4.23 *virtual tracking unit* — An entity (which could be a number of substrates or an individual die or mask group) that the factory floor control system treats as a single unit for tracking purposes.
- 4.24 *wafer carrier* — Any cassette, box, pod, or boat that contains wafers (as defined in SEMI E15).
- 4.25 *wafer extraction volume* — The open space for extracting a wafer from the cassette.
- 4.26 *wafer pick-up volume* — The space that contains entire bottom of a wafer if the wafer has been pushed to the rear of the cassette.
- 4.27 *wafer set-down volume* — The open space for inserting and setting down a wafer in the cassette.

5. Ordering Information

- 5.1 *Intended Use* — This standard is intended to



specify 300-mm cassettes over a reasonable lifetime of use, not just those in new condition. For this reason, the purchaser needs to specify a time period and the number and type of uses to which the cassettes will be put. It is under these conditions that the cassettes must remain in compliance with the requirements listed in Section 6.

5.2 Temperature Ranges — The purchaser of 300-mm cassettes needs to specify two sets of temperatures to which the cassettes might be exposed. An operating temperature range is the set of environmental temperatures in which the cassettes will remain in compliance with the requirements listed in Section 6. A temporary temperature range is the set of environmental temperatures to which the cassettes can be exposed such that when the cassettes return to the operating temperature range, the cassettes will be in compliance with the requirements listed in Section 6. Limits on exposure times to elevated temperatures should be specified. Also, the purchaser needs to specify a range of temperatures for the wafers that might be inserted in the cassettes.

5.3 Front End vs. Back End of Line — The purchaser of 300-mm carriers needs to specify whether they are to be used in the front-end-of-line (FEOL) part of the fabrication process, the back-end-of-line (BEOL) part, or both.

6. Requirements

6.1 Kinematic Couplings — The physical alignment interface on the bottom of the cassette consists of features (not specified in this standard) that mate with six pins underneath as defined in SEMI E57. Most of the dimensions of the cassette are determined with respect to the three orthogonal datum planes defined in that standard: the horizontal datum plane, the facial datum plane, and the bilateral datum plane. All of the dimensions for the cassette are bilaterally symmetric about the bilateral datum plane. The three features that mate with the pins must provide a lead-in capability that corrects a cassette misalignment no greater than $r19$ in any horizontal direction. However, it is recommended that robots placing cassettes on kinematic couplings use as little of this lead-in capability as possible to avoid wear.

6.2 Wafer Orientation and Numbering — The wafers must be horizontal when the carrier is placed on the coupling, and the wafers are numbered in increasing order from bottom to top (so the bottom wafer is wafer number 1, the next wafer up is wafer number 2, etc.). After processing at a tool, each wafer should be returned to the same slot from which it was taken.

6.3 Cassette Sides — Figure 1 shows a cross-section of the horizontal boundaries of the cassette side domains (which contain the parts of the cassette higher than $z6$ above the horizontal datum plane and lower than $z15$ above the top wafer). In this and following figures, the most heavy lines are used for surfaces that have tolerances (not surfaces that have only maximum or minimum dimensions). Table 1 defines the dimensions shown in this and following figures. The maximum protrusions of any part of the cassette from the nominal wafer center line and from the bilateral datum plane is $r5$ and $x9$, respectively. There are two optional side grip pits on each side. For optically sensing whether a cassette is properly in place, from left to right under the bottom wafer is an optical cassette sensing hole. The radius of this hole is given with both upper and lower tolerances, but the upper tolerance is only to define a minimum aperture that must be met at only one section on each side. Other than through the optical cassette sensing holes, the cassette bottom and side domains must block any line of sight passing through both of the two rectangles at $x10$ on each side bounded by $z4$, $z20$, $y2$, and $y3$.

6.4 Cassette Top — Figure 2 shows a top view of the horizontal boundaries of the cassette top domain which contains any part of the cassette higher than $z15$ above the top nominal wafer plane. The top robotic handling flanges (optional), the side grip pits (optional), and optical cassette sensing hole on the side can be seen in Figure 3, which is an oblique view of the maximum cassette dimensions (see Figure 14 to see how cassettes need not take up all of that volume). The maximum radial protrusions of the cassette top in the front and rear are $r6$ and $r12$, respectively. Dimensions $x6$, $x12$ (shown in Figure 4), and $y15$ define a vertical path for optically sensing wafers through the top and bottom domains.

6.5 Cassette Bottom — Figure 4 shows a bottom view of the horizontal boundaries of the cassette bottom domain (which contains any part of the cassette lower than $z6$ above the horizontal datum plane). At the nominal wafer center line, a circular hole with a radius of $r7$ must be present (up to a height of $z5$) in the cassette bottom to avoid interfering with pod latch pins. For moving the cassette on roller conveyors and for picking up the cassette with a fork lift, the cassette must have surfaces on the left and right open to the bottom and outside bounded by $x15$, $x16$, $r10$, $z3$ and $z4$. A cylindrical section of radius $r8$ and axis at $x11$ on the facial datum plane must be clear up to a height of $z22$ to hold the cassette firmly on the lifting forks by the use of a cylindrical pin.

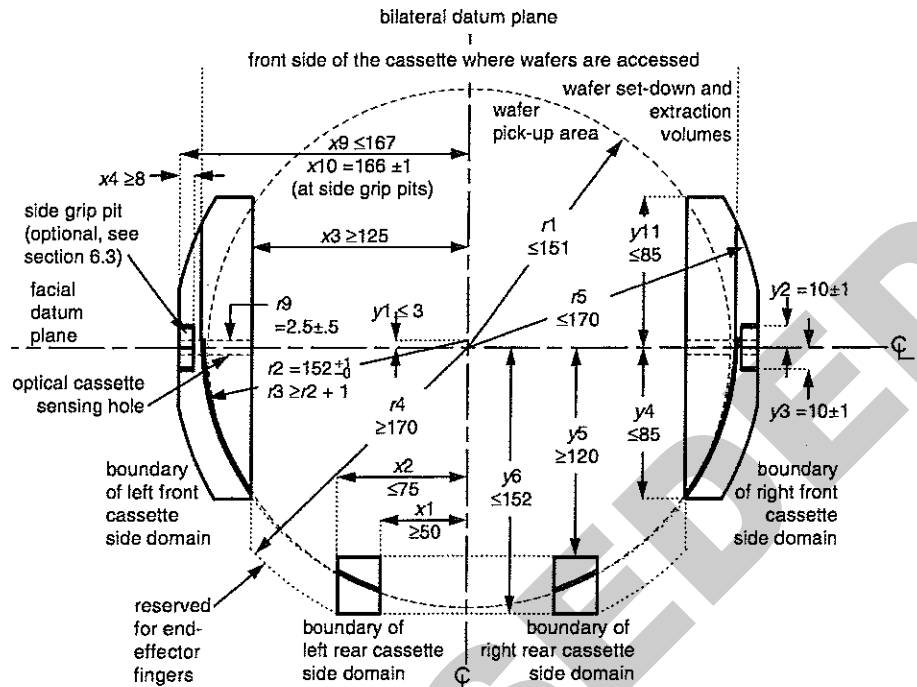


Figure 1
Cassette Side Domains

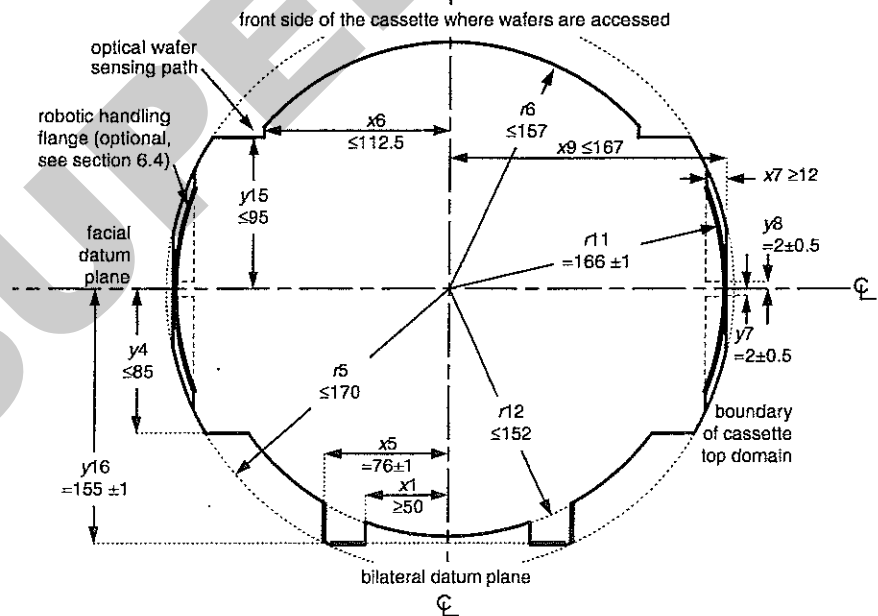


Figure 2
Cassette Top Domain

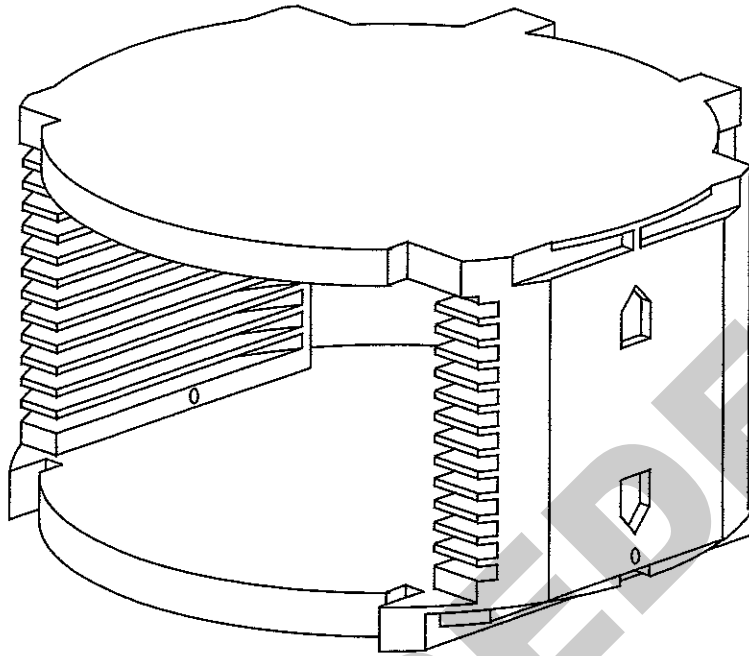


Figure 3
Oblique View of Maximum Cassette Dimensions

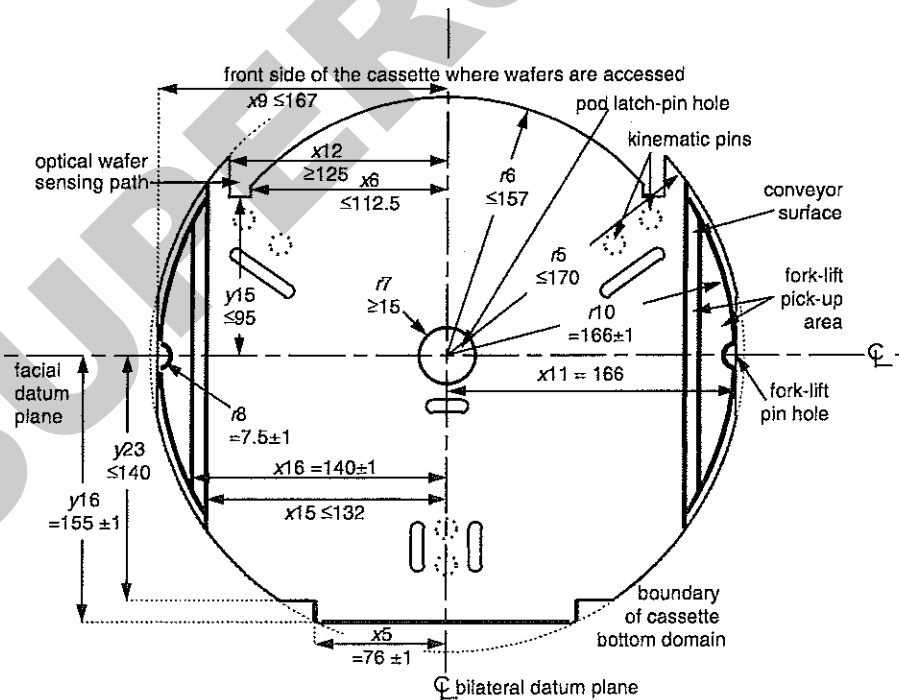


Figure 4
Cassette Bottom Domain



6.6 Carrier Sensing Pads and Info Pads — When the cassette is fully down, the carrier sensing pads (shown in Figure 5) must be $z2$ above the horizontal datum plane. It is recommended that the areas surrounding all of the carrier sensing pads be designed in conjunction with the features that mate with kinematic coupling pins so that a mechanical sensor pin cannot interfere with the lead-in function of the kinematic couplings. Other sensing pads (called info pads and given letter names) communicate information about the carrier. Note that since this is a bottom view, the positions of sensors on a load port will be switched, with the sensor for info pad A on the right and the sensor for info pad B on the left as one faces the tool from the front.

6.6.1 Info pad A (on the lower left in Figure 5) indicates the carrier capacity (the number of wafers). Info pad A must be in the down position (at $z2$ above horizontal datum plane) if the carrier holds 13 wafers and must be in the up position (at $z26$ above horizontal datum plane) if the carrier holds 25 wafers.

6.6.2 Info pad B (on the lower right in Figure 5) indicates the carrier type (cassette or box). Info pad B must be in the down position (at $z2$ above horizontal datum plane) if the carrier is a cassette and must be in the up position (at $z26$ above horizontal datum plane) if the carrier is a box.

6.6.3 Info pads C and D (slightly forward and to the outside of info pads A and B) are intended to show whether the carrier is dedicated to the front-end-of-line (FEOL) part of the fabrication process (before any metal layers have been deposited on the wafer) or to the back-end-of-line (BEOL) part of the fabrication process (during which metal contamination may be present). If such carrier differentiation is required by the user, info pads C and D must be down and up (respectively) for a front-end-of-line carrier and the opposite for a back-end-of-line carrier. If such carrier differentiation is not required by the user, info pads C and D must both be up.

6.7 Vertical Dimensions — Figures 6 through 13 show the vertical dimensions of the cassette. Note that $z8$ (the height of the bottom nominal wafer seating plane above the horizontal datum plane) and $z12$ (the distance between adjacent nominal wafer seating planes) are given as absolute distances with no tolerance. This means that the sum of actual height variations in the cassette from the kinematic coupling to the supporting features holding each wafer must be contained within the tolerance of $z10$ with no further stack-up at each higher wafer. The

method for meeting this requirement is left up to the cassette supplier.

6.7.1 The open space for the wafer set-down volume consists of a cylindrical section with radius $r2$ and a main axis parallel to and $y1$ in front of the nominal wafer center line. The top of this cylindrical section is $z11$ above the nominal wafer seating plane and its bottom is $z10$ above the nominal wafer seating plane. The implications for wafer positioning of the tolerance on $r2$ are as follows. The wafers should be placed in the cassette within a circle of radius corresponding to the smaller bound on $r2$ to avoid touching the edge of the wafer to the side of the cassette. Once the wafer has been placed, the cassette must not allow a wafer to move outside of a circle of radius corresponding to the larger bound on $r2$. There are two exceptions to this limit on wafer movement. When the wafer is pushed toward the rear of the cassette, the location of the wafer is defined by the wafer pick-up volume (see Section 6.7.3). When the cassette is gently tilted forward up to 45° , the wafers may slide forward, but it is recommended that they not extend further than $y20$ from the facial datum plane. This may be accomplished by designing the teeth supporting the wafers to include a "wafer stopper" at the front (as shown in Figure 11) that is outside of $r2$ and under $z29$. Note that use of this feature will reduce the height of the wafer extraction volume.

6.7.2 The open space for the wafer extraction volume includes a cylindrical section with radius $r3$ and a main axis parallel to and $y1$ in front of the nominal wafer center line. The top of this cylindrical section is $z11$ above the nominal wafer seating plane and its bottom is $z23$ above the nominal wafer seating plane. The wafer extraction volume also includes the extrusion out the front of the cassette of this cylindrical section and the portion of the wafer set-down volume above $z29$. The implications for wafer extraction of the definition of dimension $r3$ ($r3 \geq r2 + 1$) are as follows. The cassette must give an extra 1 mm (0.04 in.) of horizontal clearance once the wafer is picked up from wherever it ends up (within the bounds of $r2$) after transport in the cassette.

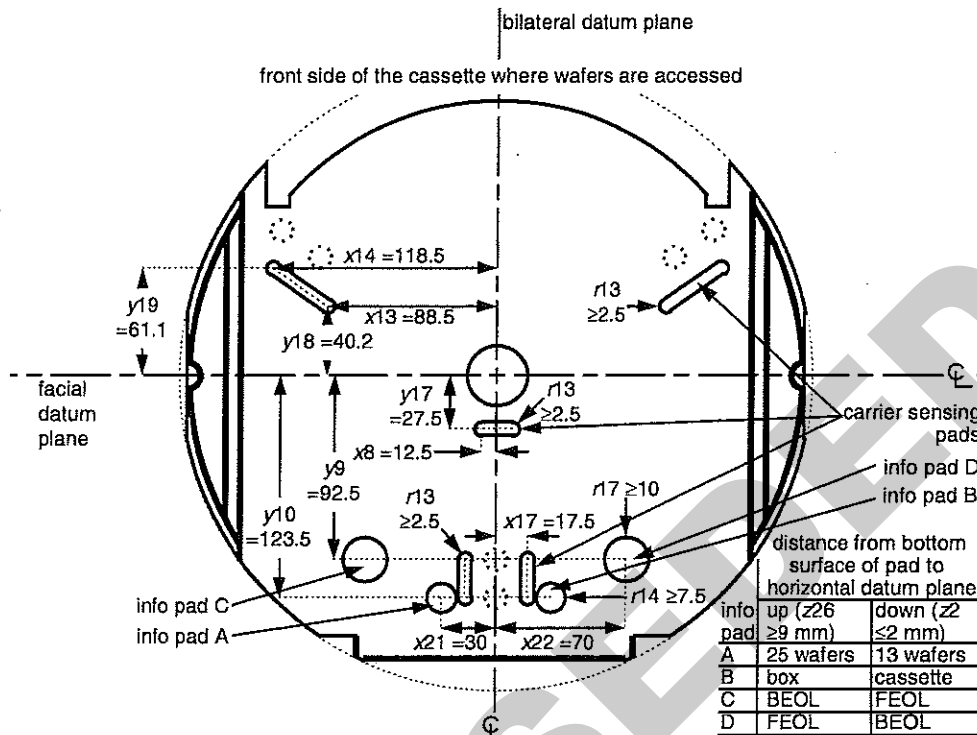


Figure 5
Carrier Sensing Pads in Bottom View

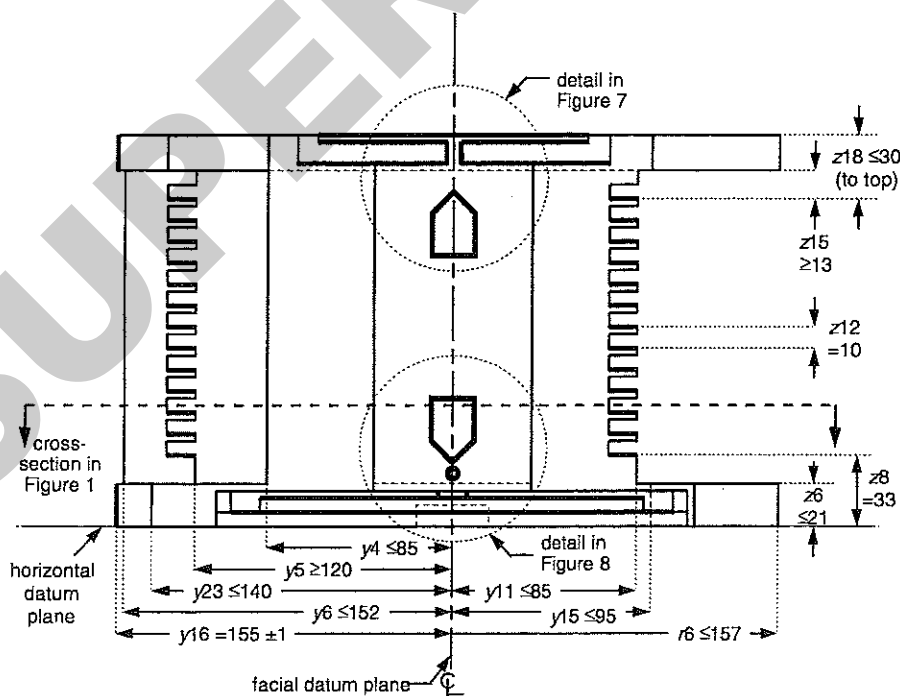


Figure 6
Side View of Cassette